Graphene

Christian Koch, Aina Marquez IFAE, July/September 2015

Tutors: Federico Sánchez, José Gabriel Macías, Thorsten Lux





GOAL

Graphene Detectors in Particle Physics Charged particle (ion) sensors
 Photosensors

Measurements

- Comparison of PSD for same R resistor and graphene layer (Hf substrate)
 Each sweep measures 1 and V for the back gated Drain-Source signal.
 Two setups; compare DC and Pulsed for

Issues

- Humidity rises electrical resistance of graphene. Experiments should be carried in Nitrogen.

 Graphene resistance increased from
- Quantum dots affect conductivity
- In the past, observed diode properties on
- Observed hysteresis during DC Voltage Sweeps in Graphene

Why Graphene?



Two main kinds: White noise



Electrical Noise

First step towards a graphene detector: characterization of electrical noise



Procedure

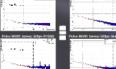
Conclusions

 \cdot 1/f lpha observed in both graphene and the resistor Resistor o=1 usually c=1.2
Not draighated in power sources
No difference between direct and pulsed current
Hysteresis observed: Impurities? Quantum
Dots? Water?...

Systematic method: lowering the voltage to 0 before each measurement.

Systematic measurement methodology developed

1



Plot Results

Coming soon

- Pulsed sweeps with shaper readout
 Nitrogen medium and temperature
- monitoring while measuring

- 3. New, purer graphene without
- 4. SiO, substrate



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GOAL

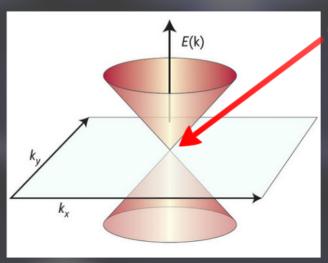
Graphene Detectors in Particle Physics

- Charged particle (ion) sensors
- Photosensors



Why Graphene?

- Graphene: flat monolayer of carbon atoms packed into a 2D layout
- Interesting electrical properties
- Semiconductor behaviour, with valence and conduction bands meeting at a single point, the Dirac Point



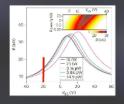
Dirac Point

(max R)

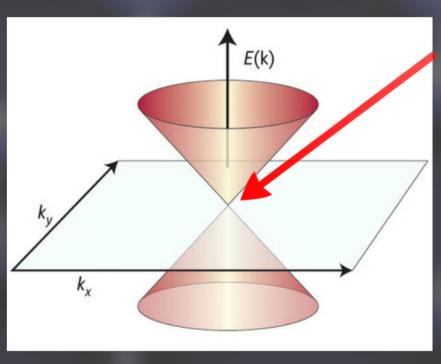
Resistance depends on cone cross-sectional area

Smaller area implies greater resistance

 When graphene is doped with Quantum Dots, trapped charged particles shift the Dirac Point because of electrical field alterations.



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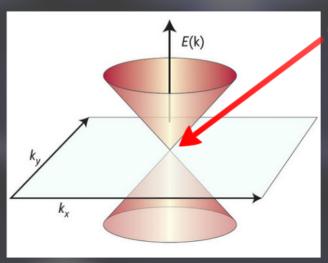
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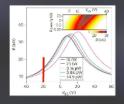
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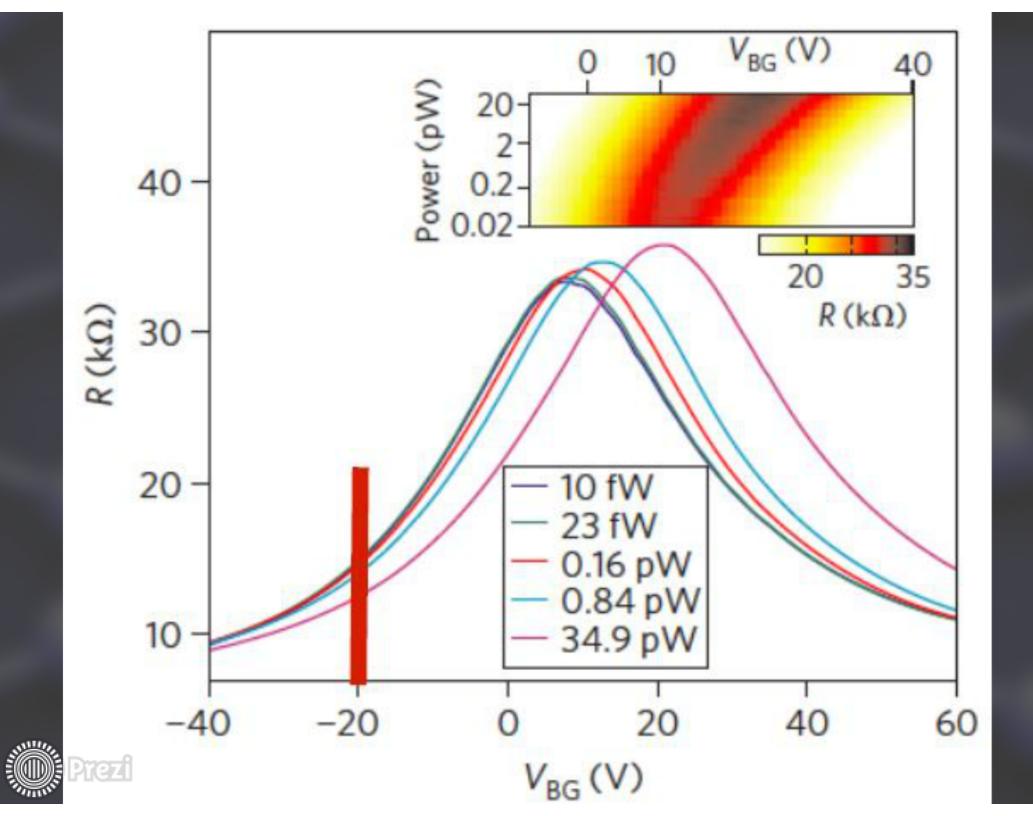
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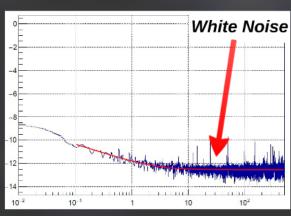


Electrical Noise

- First step towards a graphene detector: characterization of electrical noise
- Two main kinds:

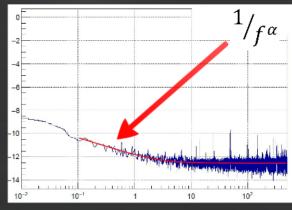
White noise

Spectrum of a random signal with constant PSD



Pink noise

Frequency spectrum for which the PSD is inversely proportional to the frequency of the signal





PSD

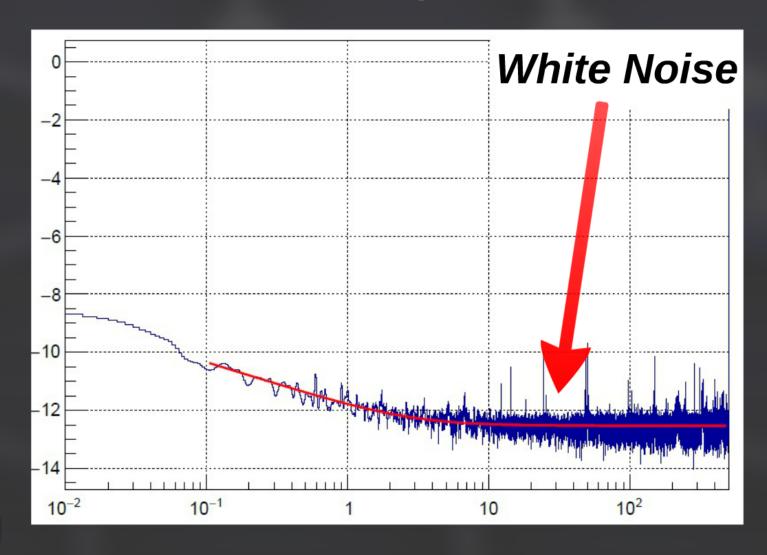
- Power Spectral Density is the frequency response of a random or periodic signal
- Distributes the average power as a function of frequency
- Average of the Fourier transform magnitude squared over a large time interval

$$S_{x}(f) = \lim_{T \to \infty} E\left\{ \frac{1}{2T} \left| \int_{-T}^{T} x(t)e^{-j2\pi ft} dt \right|^{2} \right\}$$



White noise

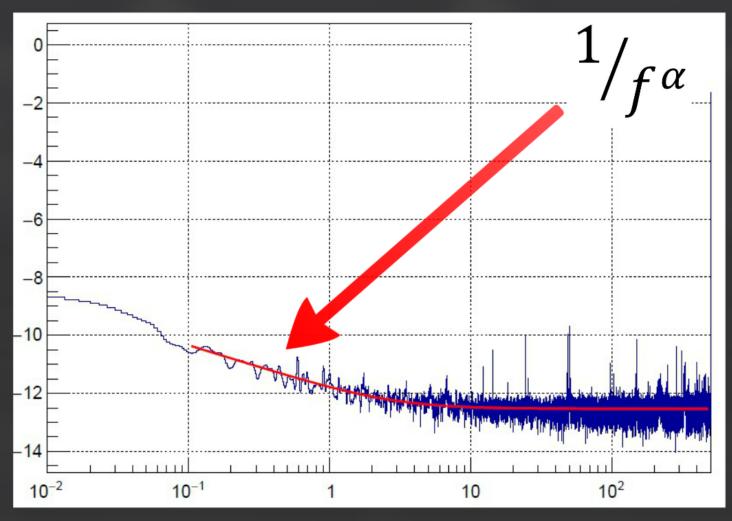
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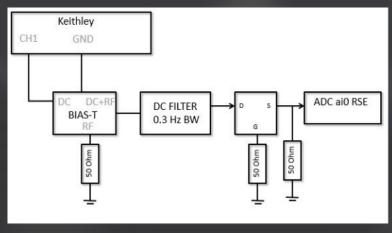




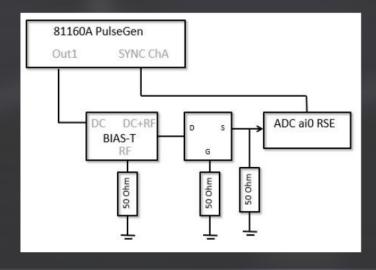
Measurements

- Comparison of PSD for same R resistor and graphene layer (Hf substrate)
- Each sweep measures f and V for the back gated Drain-Source signal.
- Two setups; compare DC and Pulsed for final detector

DC Voltage Sweep

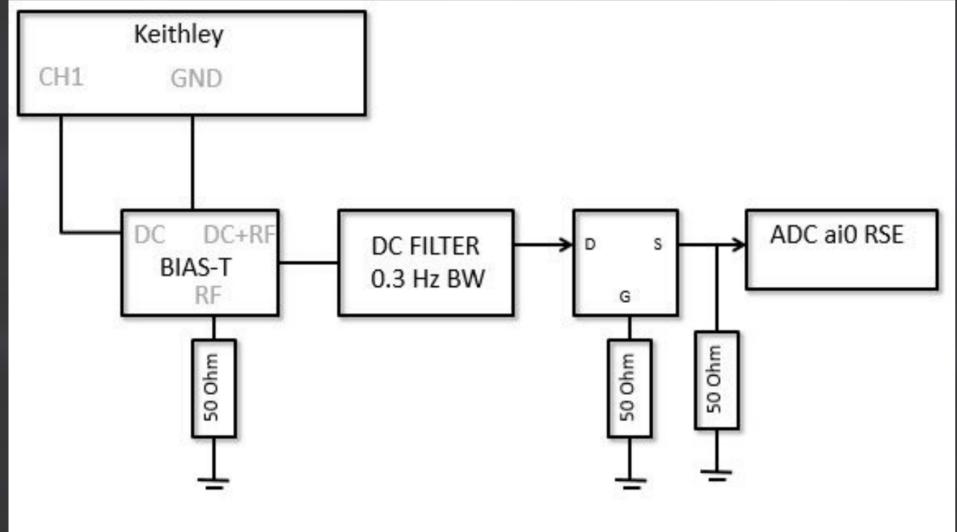


Pulsed Sweep



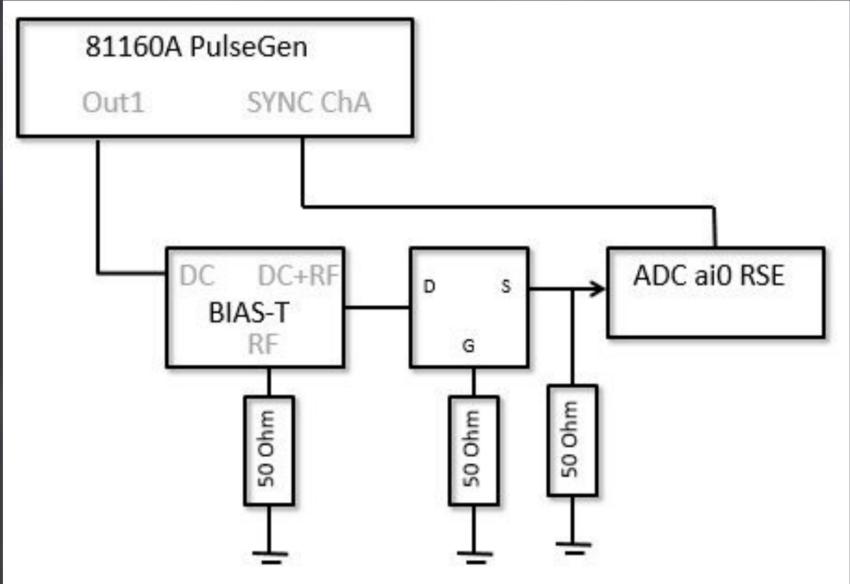


DC Voltage Sweep





Pulsed Sweep





Procedure

DC Voltage Sweeps

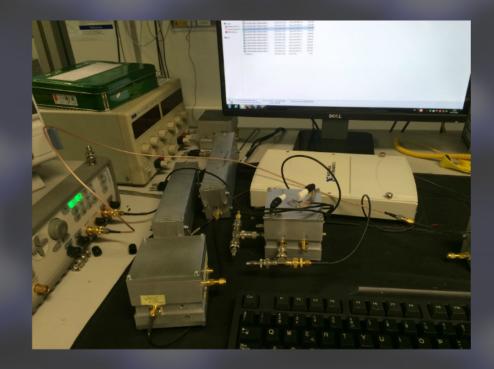
- 3 to 6 takes, 5min each
- 300kS at 1kHz
- 50mV to 1500mV

Pulsed Sweeps

- 3 takes, 5min each
- 300kS at 1kHz
- 50μs to 950μs

Long Sweeps

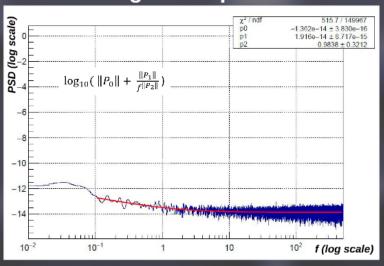
- Single takes, 30-120min
- Different voltages
- Both setups
- 1800kS at 1kHz



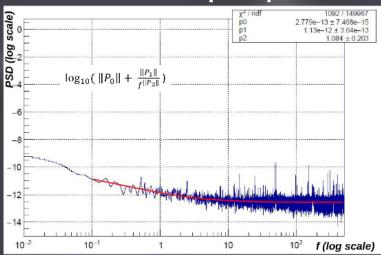


Plot Results

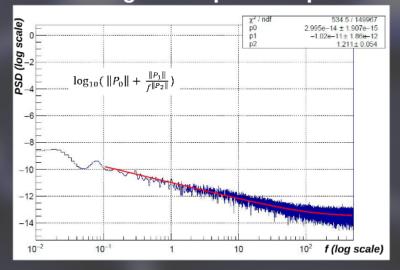
DC Voltage Sweep 1V R=1kΩ



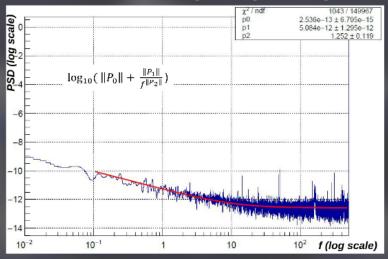
Pulse Width Sweep 500μs R=50Ω



DC Voltage Sweep 1V Graphene

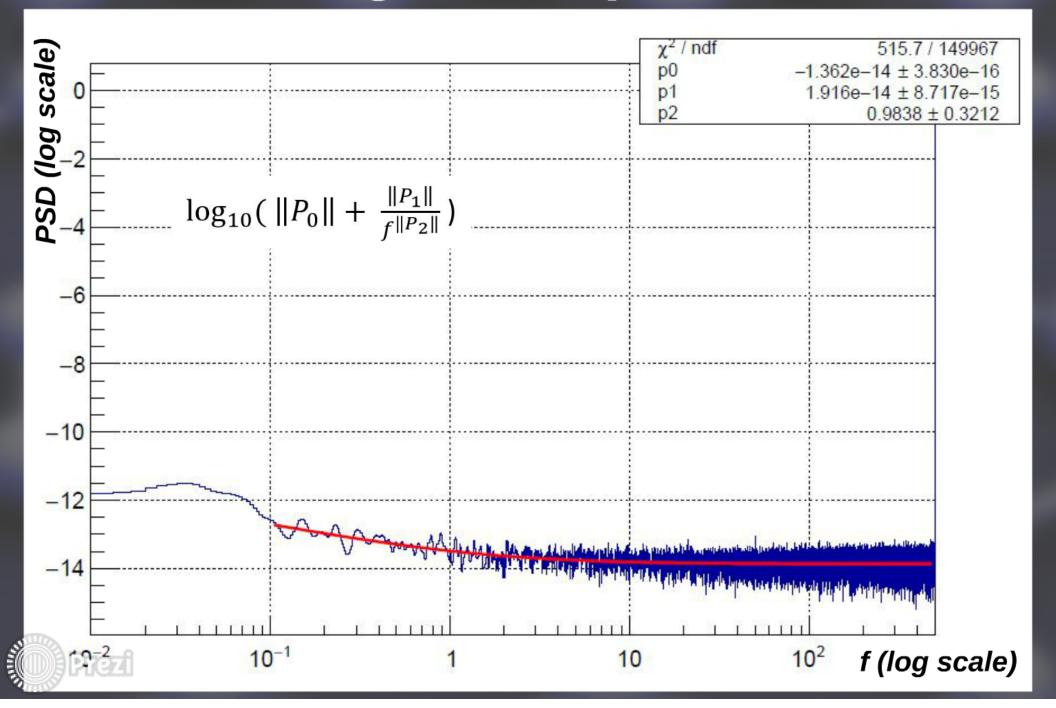


Pulse Width Sweep 500µs Graphene

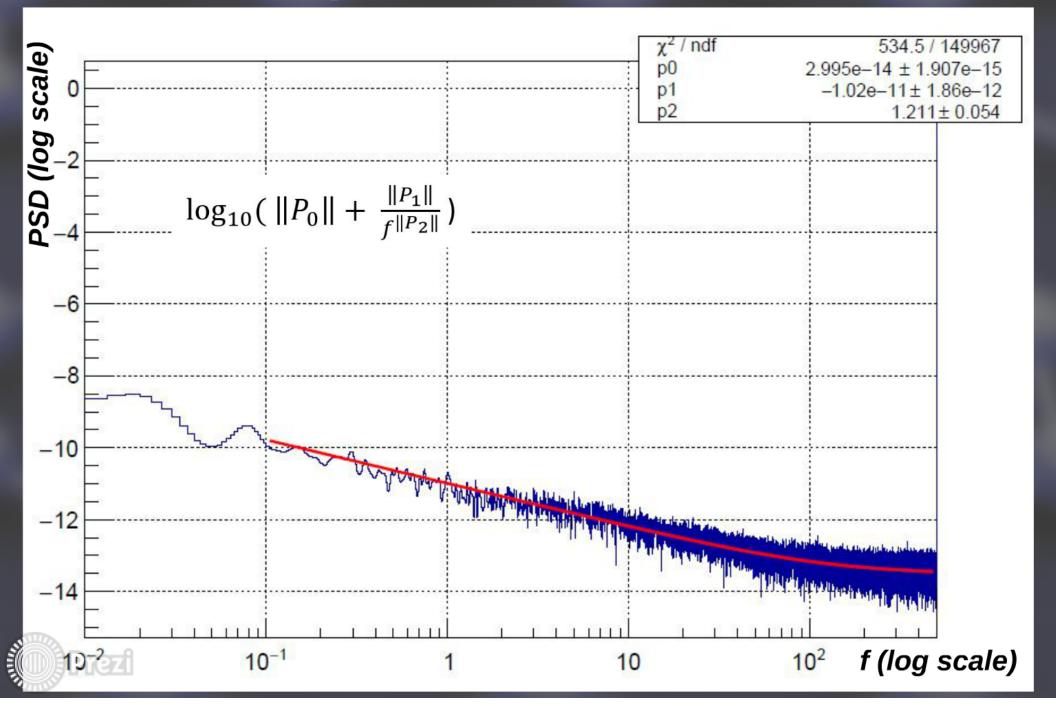




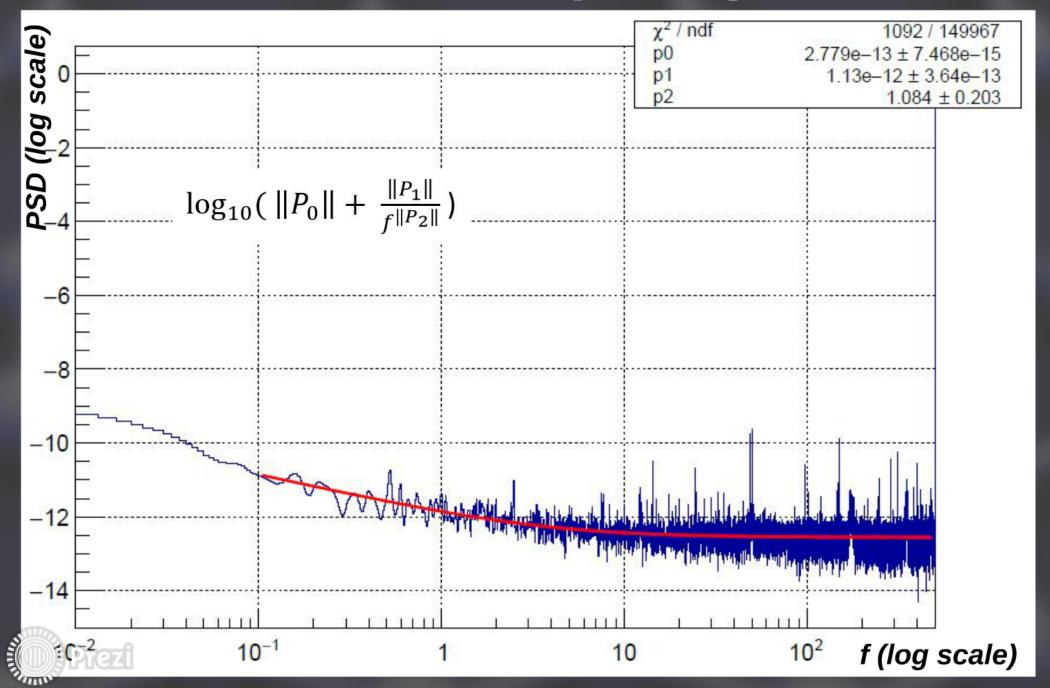
DC Voltage Sweep 1V R=1kΩ



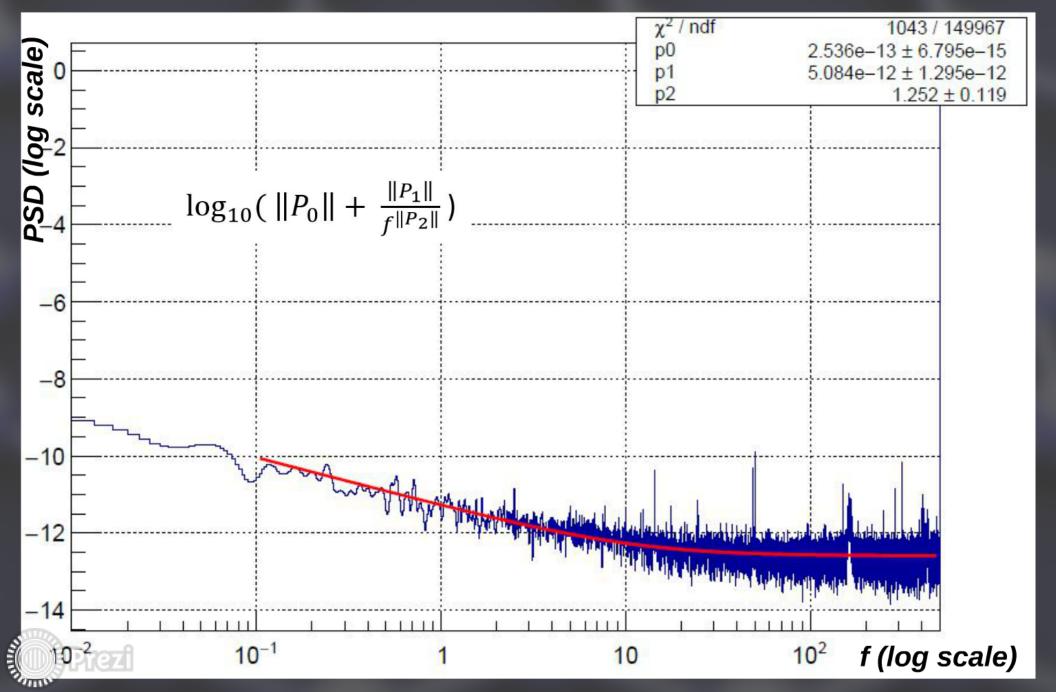
DC Voltage Sweep 1V Graphene



Pulse Width Sweep 500μs R=50Ω



Pulse Width Sweep 500µs Graphene



	DC Voltage Sweep 100mV R=1kΩ			DC Voltage Sweep 100mV Graphene		
p1	7.94·10-14	8.08 · 10 - 14	7.49·10-14	6.89·10 ⁻¹⁴	7.49·10 ⁻¹⁴	
p2	1.09·10°	1.08·10 ⁰	1.07·10°	1.12·10 ⁰	1.14·10°	1,11·10 ⁰

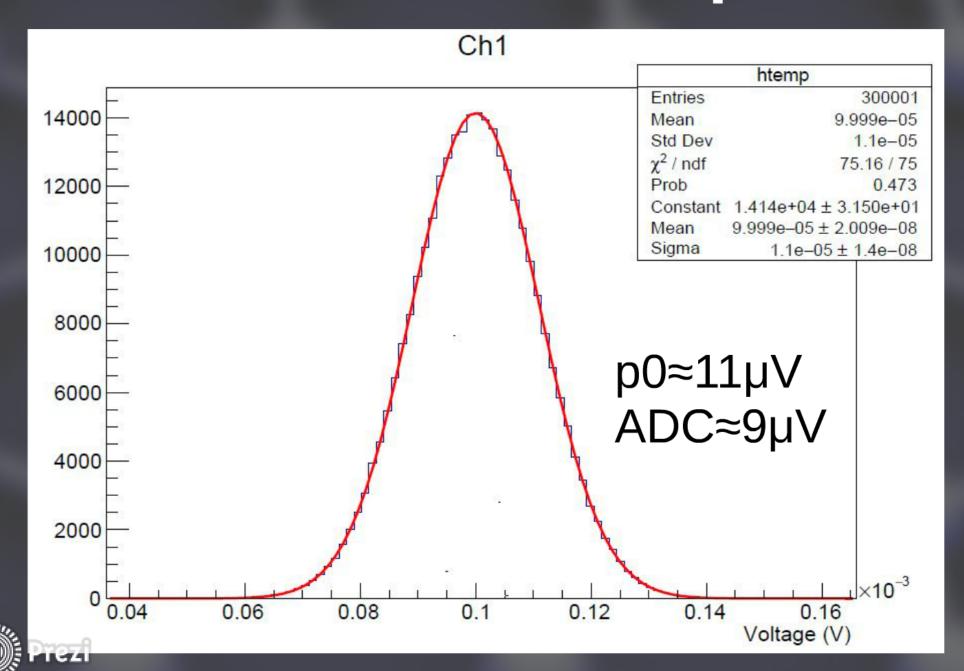
8, 3	DC Voltage Sweep 1V R=1kΩ			DC Voltage Sweep 1V Graphene		
p1	5.40·10 ⁻¹¹	5.34 · 10 - 11	1.02·10-11	1.20.10-11	1.12.10-11	1.08 · 10-11
p2	9.83·10 ⁻¹	9.75.10-1	1.21.100	1.25·10°	1.23·10 ⁰	1.24·10 ⁰

	Pulsed Sweep 500µs			Pulsed Sweep 500µs		
	R=50Ω			Graphene		
p1	1.13.10-12	9.84 · 10 - 13	9.42.10-13	5.08 · 10 - 12	4.49 · 10 - 12	4.49 · 10 - 12
p2	1.08·10 ⁰	1.14.100	9.26 · 10 - 1	1.25.100	1.14.100	1,25·10°

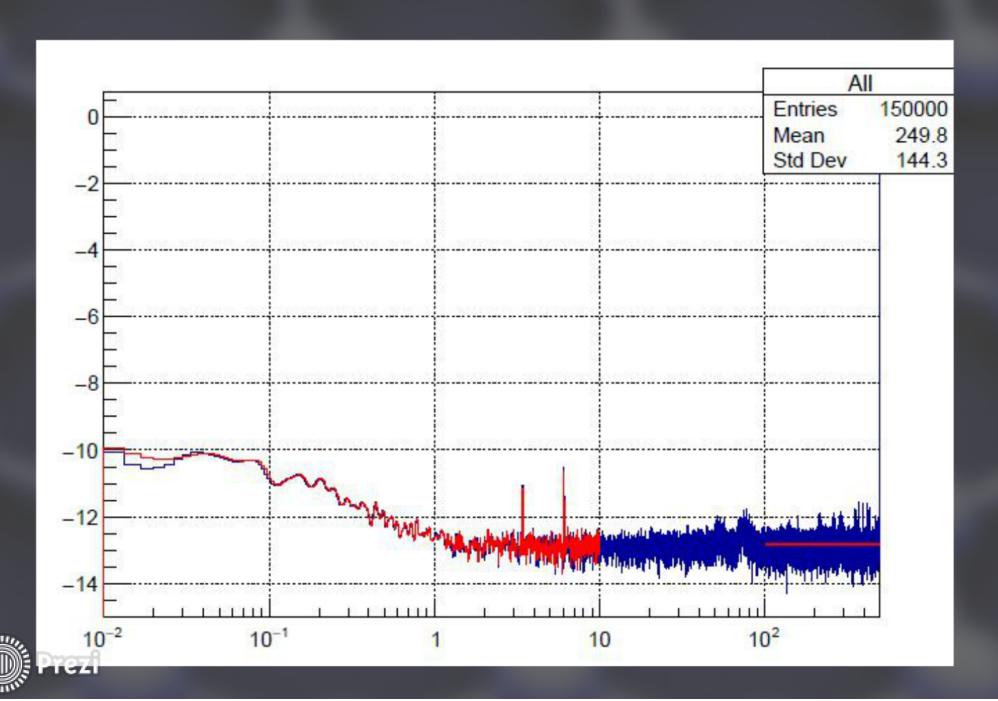


DC Source PSD

White Noise Sample

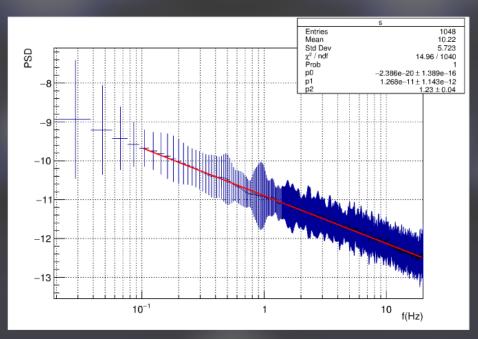


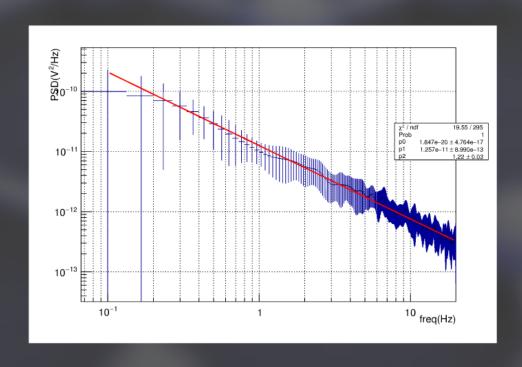
DC Source PSD



Error Estimation

- Error can be estimated with many measurements or dividing a single long one
- Average and RMS of PSD







Issues

- Humidity rises electrical resistance of graphene. Experiments should be carried in Nitrogen. Graphene resistance increased from $1k\Omega$ to $6.2k\Omega$
- Quantum dots affect conductivity
- In the past, observed diode properties on Hf substrate
- Observed hysteresis during DC Voltage Sweeps in Graphene



Conclusions

- $1/f^{\alpha}$ observed in both graphene and the resistor
 - Resistor α≈1
 - Graphene α>1, usually α≈1.2
- Not originated in power sources
- No difference between direct and pulsed current
- Hysteresis observed: Impurities? Quantum Dots? Water? ...
- Systematic method: lowering the voltage to 0 before each measurement

Systematic measurement methodology developed



Bibliography conclusions

- Small collection on graphene noise
- Even smaller on 1/f in graphene
- No results on α (p2) value
- Considerable amount of papers about influence of impurities in graphene resistance (especially water)



Coming soon

Short term

- 1. Pulsed sweeps with shaper readout
- 2. Nitrogen medium and temperature monitoring while measuring

Long term

- 3. New, purer graphene without
- Quantum Dots
- 4. SiO₂ substrate



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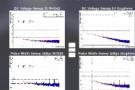
Electrical Noise

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- Two main kinds:



Procedure

- Long Sweeps
 Single takes, 30-120min
 Different voltages
 Both setups
 1800kS at 1kHz



Plot Results

Conclusions

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 Not originated in power sources
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